

**Search Notes**

Application/Control No.

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Examiner

Ha T. Nguyen

Applicant(s)/Patent under  
Reexamination

BENDALE ET AL.

Art Unit

2812

**SEARCHED**

Class	Subclass	Date	Examiner
Updated	search	4/29/2005	HN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
29	25.03	4/29/2005	HN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search	4/29/2005	HN